

Search Notes



Application/Control No.

10/659,101

Examiner

Randall Chin

Applicant(s)/Patent under
Reexamination

CHAN ET AL.

Art Unit

1744

SEARCHED

Class	Subclass	Date	Examiner
15	143.1	↓	↓
15	167.1	8/1/2005	RC
15	22.1	↓	↓
UPDATED SEARCH		3/5/06	RC
D4	138	↓	↓
UPDATED SEARCH		7/5/06	RC
UPDATED SEARCH		10/19/06	RC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor name search	8/1/2005	RC

08/08/06
07/08/06
10/19/2006